



Attorney Docket No. 0756-7275

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Hidekazu MIYAIRI et al.

Serial No. 10/808,499

Filed: March 25, 2004

For: METHOD FOR TESTING

SEMICONDUCTOR FILM,

SEMICONDUCTOR DEVICE AND

MANUFACTURING METHOD

THEREOF

) Group Art Unit: 2857

) Examiner: Jeffrey R. West

) CERTIFICATE OF MAILING

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) Adelle M. Stanger

)

**AMENDMENT**

Honorable Commissioner of Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

In response to the Official Action dated June 25, 2007, please consider the following amendments and remarks in connection with the above-identified application.

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks** begin on page 11 of this paper.